AMENDMENTS TO THE CLAIMS

- 1. (Currently Amended) A non-invasive spectrometric device for assessing the <u>a</u> level of hemoglobin in mammalian tissues comprising:
- (a) <u>a</u> wavelength filter <u>means</u> <u>configured to receive light reflected from an area of tissue and for transmitting or reflecting <u>a subset of</u> wavelengths of light <u>reflected from the</u> area of tissue;</u>
- (b) <u>a</u> light intensity sensor means arranged and disposed to measure the intensity of the wavelengths transmitted or reflected by the wavelength filter means and generate an electrical signal <u>as a function of the light reflected from the area of tissue; therefrom,</u>
- (e) an output processor processing means connected to the light intensity sensor means and configured to receive and process the electrical signal output therefrom, wherein the output processor is configured to calculate the level of hemoglobin as a function of the electrical signal; and
- (d) <u>a</u> display means connected to the output <u>processor</u> processing means <u>and</u> <u>configured</u> to display the <u>output</u> <u>estimated level of hemoglobin;</u>

wherein the wavelength filter comprises at least one pair of planar non-polarizing substrates in parallel opposed relation, at least one layer of light-wavelength modulating material disposed between the pair of planar substrates to achieve spectral coverage in the visible light spectrum, and a power source in power-providing communication with the substrates;

wherein each of the non-polarizing substrates are configured to pass at least a portion of the visible spectrum.

- 2. (Currently Amended) The device of claim 1 wherein the light intensity sensor means is arranged and disposed in stacked relation to the wavelength filter means such that wavelengths of light are transmitted through the wavelength filter means into the light intensity sensor means.
- 3. (Currently Amended) The device of claim 1 wherein the light intensity sensor means is arranged and disposed in angular relation to the wavelength filter means such

that wavelengths of light are reflected from the wavelength filter means into the light intensity sensor means.

- 4. (Canceled)
- 5. (Currently Amended) The device of claim [[4]] 1 wherein the substrates are electrically conducting substrates.
- 6. (Currently Amended) The device of claim [[4]] 1 wherein the light-wavelength modulating material comprises deformed helix ferroelectric liquid crystals (DH-FLC), electrically tuned to exhibit predetermined wavelength selection properties.
- 7. (Currently Amended) The device of claim 6 wherein the molecules in the layers of the DH-FLC are aligned perpendicular to the surfaces of the planer planar substrates.
- 8. (Original) The device of claim 5 wherein the power source is in electrical communication with the substrates to create an inplane electric field.
- 9. (Currently Amended) The device of claim [[4]] 1 wherein the power source is in thermal communication with one of the pair of substrates to create a temperature change in the wavelength modulating material.
- 10. (Currently Amended) The device of claim 9 wherein the power source is a transparent resistive heater positioned on the planer planar exterior surface of one of the pair of substrates.
- 11. (Original) The device of claim 5 wherein the light-wavelength modulating material comprises a layer of holographic polymer dispersed liquid crystals (H-PDLC).
- 12. (Original) The device of claim 11 wherein one layer of H-PDLC is arranged between two parallel-opposed electrically conducting substrate layers so as to form a

spatial gradient in the H-PDLC from one edge of the substrate layers to the opposing edge of the substrate layers.

- 13. (Original) The device of claim 11 wherein one layer of H-PDLC is arranged between two parallel-opposed electrically conducting substrate layers and wherein the H-PDLC has an index of refraction variable in response to an applied electric field.
- 14. (Original) The device of claim 11 comprising a stack composed of a plurality of layers of H-PDLC arranged in alternating, superposed, relation to a plurality of substrate layers, wherein the number of substrate layers equals the number of layers of H-PDLC plus one.
- 15. (Currently Amended) The device of claim [[12]] <u>14</u> wherein the stack is composed of between two and twenty layers of H-PDLC layers.
- 16. (Original) The device of claim 5 wherein the light-wavelength modulating material comprises at least on layer of cholesteric liquid crystals (CLC).
- 17. (Currently Amended) The device of claim 14 forming 16 comprising a stack composed a plurality of CLC layers arranged in alternating, superposed, relation to a plurality of substrate layers, the plurality of CLC layers having the capacity to reflect light of different, per-determined wavelengths, the stack having a number of substrate layers one greater than the number of CLC layers and wherein the power source produces electrical energy perpendicular to [[the]] a pitch axis of the CLC layers.
- 18. (Currently Amended) The device of claim [[15]] <u>16</u> further comprising a passive optical element disposed in parallel relation between two reflective CLC of opposite-handedness.
- 19. (Currently Amended) The device of claim 16, composed of one layer of CLC disposed between two layers of electrically conducting substrate, wherein the one layer of

CLC is <u>configured</u> subjected to a in-plane electric field to produce different pitch sizes as the electric field is <u>varied</u> increased.

20. (Currently Amended) The device of claim $\underline{1}$ wherein the light intensity sensor means is selected from the group consisting of an array of CCD and a photodiode.